

## WHAT IS CLAIMED IS:

1. An automated computer-implemented method for reducing the number of  
5 distinct integrated circuit (IC) logic cells used to implement an IC design, said method  
comprising the steps of:
- receiving a functional description for a cell;
- 10 receiving a design constraint for said cell, said design constraint related to a context-  
of-use for said cell in said IC design; and
- determining an implementation of said cell based on said functional description and  
said design constraint.
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2. The method of claim 1, wherein said constraint is selected from a group of  
metrics consisting of: timing, power, area, noise margins, slew, input/output capacitances,  
switching capacitances, drive strength, footprint size, and pin-placement for said cell.
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3. The method of claim 1, further comprising the step of determining whether  
said functional description and said constraint can be matched by an existing cell.
4. The method of claim 3, further comprising the step of determining a signature  
for said cell based on said functional description and said constraint.
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5. The method of claim 4, further comprising the step of evaluating said  
signature against a signature of an existing cell to determine a possible match.
6. The method of claim 1, wherein said step of determining comprises at least

one possible input permutation for said cell.

7. The method of claim 1, wherein said step of determining comprises at least one possible input complement for said cell.

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8. The method of claim 4, wherein said signature is determined for utilizing each said constraint.

9. The method of claim 4, wherein said signature comprises a constraint for timing of said cell.

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10. The method of claim 9, wherein said constraint for timing of said cell comprises a sorted list of rise times and fall times.

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11. The method of claim 10, further comprising the step of comparing said sorted set of rise and fall times against a sorted set of available rise and fall times of a cell available in a library, or of a cell created on-the-fly.

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12. The method of claim 1, further comprising the step of characterizing said cell based on said constraint, wherein said constraint is related to a context-of-use for said cell in said IC design.

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13. The method of claim 12, wherein said context includes at least a region of said IC design .

14. The method of claim 12, wherein said context-of-use is utilized to define a set of characterization vectors applicable to said cell.

15. The method of claim 14, wherein said context may include a factor not

affecting the size of said set of characterization vectors applicable to said cell.

16. The method of claim 15, wherein said set of characterization vectors applicable to said cell comprises a set of restrictions on process corners at which said cell is  
5 characterized.

17. The method of claim 1, wherein characterization of said IC design is accomplished by characterizing partitions of said IC design at a transistor level.

18. The method of claim 17, wherein said partitions are realized as at least one  
10 standard-cell.

19. The method of claim 17, wherein said partitions can be formed in a region of said IC design based on a design criteria.  
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20. The method of claim 17, wherein said design criteria is selected from a group consisting of timing, area, power, and signal integrity.

21. The method of claim 17, wherein said partitions comply with a standard-cell  
20 based IC design flow.

22. A storage media including computer readable program instructions for an automated computer-implemented method for reducing the number of distinct integrated circuit (IC) logic cells used to implement an IC design, said storage media comprising:  
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program instructions for receiving a functional description for a cell;

program instructions for receiving a design constraint for said cell, said design constraint related to a context-of-use for said cell in said IC design; and

program instructions for determining an implementation of said cell based on said functional description and said design constraint.

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